

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/773,490	BHEDA ET AL.	
	Examiner	Art Unit	
	Alicia M. Toscano	1712	Page 1 of 1

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*	D	US-6,630,050	10-2003	Moeller et al.	156/331.7
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*	N	JP 06100767 A	04-1994	Japan	YAMAMOTO et al.	
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**NON-PATENT DOCUMENTS**

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	U	/ Sigma-Aldrich product data, from www.sigmaaldrich.com, 6 pages
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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